

Page: 1 of 50

## TEST REPORT

Project No.: TM-2302000510P

Applicant: 7STARLAKE Co., Ltd.

Address: 2F., No.190, Sec 2, Zhongxing Rd., Xindian Dist.,

New Taipei City, 23146, Taiwan.

Manufacturer: 7STARLAKE Co., Ltd.

Address: 2F., No.190, Sec 2, Zhongxing Rd., Xindian Dist.,

New Taipei City, 23146, Taiwan.

**Equipment Under Test (EUT):** 

Name: Millitary IP66 Mission GPU Computer

Brand Name: 7starlake Model No.: AV600 Added Model(s): N/A

#### Standards:

J. G. 1. G.	
EN 55032: 2015 + A11: 2020, Class A CISPR 32: 2015 (Ed 2.0) + C1: 2016	BS EN 55032: 2015 + A11: 2020
EN IEC 61000-3-2: 2019 + A1: 2021	BS EN IEC 61000-3-2: 2019 + A1: 2021
EN 61000-3-3: 2013 + A1: 2019 + A2: 2021	BS EN 61000-3-3: 2013 + A1: 2019 + A2: 2021
EN 55035: 2017 + A11: 2020	BS EN 55035: 2017 + A11: 2020
IEC 61000-4-2: 2008	IEC 61000-4-6: 2013 + COR1: 2015
IEC 61000-4-3: 2020 (Ed. 4.0)	IEC 61000-4-8: 2009
IEC 61000-4-4: 2012	IEC 61000-4-11: 2020 + COR1: 2020 + COR2: 2022 (Ed. 3.0)
IEC 61000-4-5: 2014 + A1: 2017	

Date of Sample Receipt: February 24, 2023

Date of Test : March 2, 2023 ~ June 5, 2023

Date of Issue : June 20, 2023

#### Remarks:

This test report can be used for CE and UKCA marking application which is based on equivalent requirements between UK and EU. It is appropriate using designated standards to provide presumption of conformity with GB law.

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#### Disclaimer

Variants information between/among model numbers / trademarks is provided by the applicant, test results of this test report are applicable to the sample EUT received of main test model name

Approved By

J. 40 Lee

Date

June 20, 2023

Jason Lee (Section Manager)





Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 90 days only. 除非另有說明,此報告結果僅對測試之樣品負責,同時此樣品僅保留 90 天。本報告未經本公司書面許可,不可部份複製。

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Page: 2 of 50

Revision History			
Revision Report Number Description Issue Da		Issue Date	
00	TMXD2302000693DE	Original.	June 20, 2023

Note:



Page: 3 of 50

## **Contents**

1.	GEN	NERAL DESCRIPTION	4
	1.1 1.2 1.3 1.4 1.5 1.6 1.7 1.8 1.9 1.10	GENERAL DESCRIPTION OF EUT  DETAILS OF EUT  DESCRIPTION OF SUPPORT UNITS  I/O PORT DESCRIPTION  DECISION OF TEST MODE  THE FINAL TEST MODE OF THE EUT  CONFIGURATION OF TESTED SYSTEM  OPERATION PROCEDURE  SUMMARY OF RESULTS  REPORTING STATEMENTS OF CONFORMITY  DEVIATION	4 5 6 6
2.	EMI	SSION	8
	2.1 2.2 2.3	LIMIT  CONDUCTED EMISSION  RADIATED EMISSION	10
3.	HAF	RMONICS	18
	3.1 3.2	TEST INSTRUMENTS	18
		CKER	
	4.1 4.2	TEST INSTRUMENTS  MEASUREMENT DATA	
5.	IMM	IUNITY	20
	5.1 5.2 5.3 5.4 5.5 5.6 5.7 5.8 5.9	STANDARD PERFORMANCE CRITERIA DESCRIPTION  SPECIAL PERFORMANCE CRITERIA DESCRIPTION  TEST OF IEC 61000-4-2  TEST OF IEC 61000-4-3  TEST OF IEC 61000-4-5  TEST OF IEC 61000-4-6  TEST OF IEC 61000-4-8  TEST OF IEC 61000-4-11	21 32 34 35 36 37
		DIX	
		OGRAPH OF TESTING GENERAL SET-UP	



Page: 4 of 50

# 1. General Description

## 1.1 General Description of EUT

Name of EUT	Millitary IP66 Mission GPU Computer	
Brand Name	7starlake	
Model No.(s)	AV600	
Added Model(s)	N/A	

#### 1.2 Details of EUT

EUT Power Rating	18-36VDC
Highest internal frequency	2600MHz

#### **Accessories Cable List**

Cable Type	Core	Length	Category	Shielding/Non-shielding

## 1.3 Description of Support Units

#### **EUT Devices**

20: 20::000				
No.	Equipment	Model No.	Brand Name	
1	MB	OXY-5741	7StarLake	
2	CPU(2.0GHz)	Xeon E-2276ML	Intel	
3	GPU	RTX™ A1000	NVIDIA	
4	Memory (GDDR6) (4GB)	4G GDDR6	NVIDIA	
5	DRAM	DDR4 32G	Samsung	
6	Storage (SATA) (128G)	NA	7StarLake	

#### **Peripherals Devices**

No.	PRODUCT	MANUFACTURER	MODEL NO.	SERIAL NO.
1-2	USB Storage	Transcend	TS128MJF2A	N/A
3	USB Mouse	Logitech	M-U0026	N/A
4	USB Keyboard	Logitech	Y-U0011	N/A
5	DC Power Supply	iDRC	DSP-150	N/A
6	Monitor	ASUS	PA248Q	G5LMQS071284
7	Monitor	ASUS	PA248Q	G5LMQS071275
8	Server PC	Dell	T3610	57TT032
9	COM/DIO Loopback	N/A	N/A	N/A
10	Ground	N/A	N/A	N/A



Page: 5 of 50

**Support Equipment Used in Tested Cable** 

No.	Cable Type	Core	Length	Shielding/Non-shielding
1-2	USB	N/A	2.01m	Shielding
3	USB	N/A	1.8m	Shielding
4	USB	N/A	1.8m	Shielding
5	DC Power	N/A	N/A	N/A
6	DVI	N/A	2.03m	Shielding
7	DVI	N/A	2.03m	Shielding
8	RJ45	N/A	20m X2	Shielding
9	COM/DIO	N/A	2.02m	Non-shielding
10	Ground	N/A	1.8m	Non-shielding

## 1.4 I/O Port Description

	I/O Port Types	Q'TY
1.	DVI Port	2
2.	LAN/USB Port	1
3.	COM/DIO Port	1

#### 1.5 Decision of Test Mode

The test configuration modes are as the following:

#### **Conduction Mode (Power port):**

1 Normal Mode	28VDC
---------------	-------

#### **Conduction Modes (Wired network ports):**

•		
1		10Mbps
2	LAN 1	100Mbps
3		1Gbps
4	LAN 2	1Gbps

#### **Radiation Mode:**

4	Normal Mode	28VDC
'	Normal Mode / 1-6GHz	ZOVDC

### 1.6 The Final Test Mode of the EUT

After the preliminary scan, the following test mode was found to produce the highest emission level.

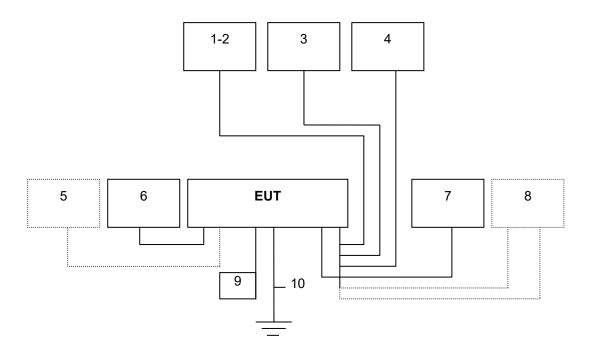
	7111001011 10 VOI.			
Final Test Mode				
Conducted Emission	Mode 1			
ISN	Mode 2			
Radiated Emission Below 1GHz	Mode 1			
Radiated Emission Above 1GHz	Mode 1			
Harmonics & Flicker	N/A			
Immunity	Mode 1			

Then, the above highest emission mode of the configuration of the EUT and cable was chosen for all final test items.



Page: 6 of 50

## 1.7 Configuration of Tested System



## 1.8 Operation Procedure

- 1. Windows 10 boots system.
- 2. Run colorbarmove.mp4 to activate all peripherals for test EUT.
- 3. Run Burnintest.exe to activate all peripherals for test EUT.
- 4. Run Lantest20.exe to ping 192.168.0.2&27 -t (EUT), ping 192.168.0.1&24 -t (Server PC).



Page: 7 of 50

#### 1.9 Summary of Results

Emission				
Standard Test Type				
EN 55032: 2015 + A11: 2020	Conducted Emission	PASS		
CISPR 32: 2015 (Ed 2.0) + C1: 2016	ISN	PASS		
BS EN 55032: 2015 + A11: 2020	Radiated Emission	PASS		
EN IEC 61000-3-2: 2019 + A1: 2021 BS EN IEC 61000-3-2: 2019 + A1: 2021	Harmonic current emissions	N/A		
EN 61000-3-3: 2013 + A1: 2019 + A2: 2021 BS EN 61000-3-3: 2013 + A1: 2019 + A2: 2021	Voltage changes, voltage fluctuations & flicker	N/A		

Immunity					
Standard	Test Type	Result	Performance Criteria		
IEC 61000-4-2: 2008	ESD	PASS	В		
IEC 61000-4-3: 2020 (Ed. 4.0)	RS	PASS	A		
IEC 61000-4-4: 2012	EFT	PASS	В		
IEC 61000-4-5: 2014 + A1: 2017	Surge	PASS	В		
IEC 61000-4-6: 2013 + COR1: 2015	CS	PASS	Α		
IEC 61000-4-8: 2009	PFMF	N/A	A		
IEC 61000-4-11: 2020 + COR1: 2020 + COR2: 2022 (Ed. 3.0)	DIP	N/A	C/C/B		

## 1.10 Reporting Statements of Conformity

The conformity statement in this report is based solely on the test results, measurement uncertainty is excluded.

#### 1.11 Deviation

No deviation from the mentioned test methods and applicable standards.



Page: 8 of 50

## 2. EMISSION

#### 2.1 Limit

#### **Maximum permissible level of Line Conducted Emission**

FREQUENCY	Class A(dBuV)		Class B(dBuV)	
(MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

Note: The lower limit shall apply at the transition frequency.

# <u>Maximum permissible level of Common Mode Conducted Emission</u> (<u>Asymmetric Mode</u>)

#### Class A

FREQUENCY	Voltage Limit(dBuV)		Current Limit(dBuA)	
(MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5 97 - 87		84 - 74	53 - 43	40 - 30
0.5 - 30.0	87	74	43	30

Class B

Oldes B						
FREQUENCY	Voltage Limit(dBuV)		Current Limit(dBuA)			
(MHz)	Quasi-peak Average		Quasi-peak	Average		
0.15 - 0.5	84 - 74	74 - 64	40 - 30	30 - 20		
0.5 - 30.0	74	64	30	20		

Note: The lower limit shall apply at the transition frequency.

#### Maximum permissible level of Radiated Emission measured at 10 meter

FREQUENCY	Class A(dBuV/m)	Class B(dBuV/m)	
(MHz)	Quasi - peak	Quasi - peak	
30 - 230	40	30	
230 - 1000	47	37	

Note: The lower limit shall apply at the transition frequency.



Page: 9 of 50

#### Maximum permissible level of Radiated Emission measured at 3 meter

Frequency range	Class A(dBuV/m)	Class B(dBuV/m)
(MHz)	Quasi - peak	Quasi - peak
30 - 230	50	40
230 - 1000	57	47

Note: The lower limit shall apply at the transition frequency.

#### **Limits above 1 GHz**

### Limits for radiated disturbance of Class A ITE at a measurement distance of 3m

Frequency range	Average Limit	Peak Limit
(GHz)	dB(µV/m)	dB(μV/m)
1 - 3	56	76
3 - 6	60	80

Note: The lower limit applies at the transition frequency.

#### Limits for radiated disturbance of Class B ITE at a measurement distance of 3m

Frequency range	Average Limit	Peak Limit
(GHz)	dB(μV/m)	dB(μV/m)
1 - 3	50	70
3 - 6	54	74

Note: The lower limit applies at the transition frequency.

#### Requirements for radiated emissions from FM receivers

Frequency range		Measurement			
(MHz)	Facility	Distance (m)	Detector type / Bandwidth	Fundamental	Harmonics
30 - 230		SAC 10	Quasi Peak / 120 kHz	50	42
230 - 300	OATS/SAC				42
300 - 1000			IZU KIIZ		46
30 - 230			Ougoi Dook /		52
230 - 300	OATS/SAC	3	Quasi Peak / 120 kHz	60	52
300 - 1000			IZU KMZ		56

These relaxed limits apply only to emissions at the fundamental and harmonic frequencies of the LO. Signals at all other frequencies shall be compliant with the limits

Note: SAC: Semi Anechoic Chamber OATS: Open Area Test Site



Page: 10 of 50

#### 2.2 Conducted Emission

#### 2.2.1 Test Instruments

	Conducted Emission Room # A										
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due						
Pulse Limiter	Schwarzbeck	VTSD 9561-F	BNC#211	03/22/2022	03/21/2023						
BNC CABLE	EMEC	EMG178	BNC#A9	03/22/2022	03/21/2023						
<b>EMI Test Receiver</b>	R&S	ESCI	100234	04/26/2022	04/25/2023						
Pulse Limiter	Schwarzbeck	VTSD 9561-F	BNC#211	03/22/2022	03/21/2023						
BNC CABLE	EMEC	EMG178	BNC#A9	03/22/2022	03/21/2023						
<b>EMI Test Receiver</b>	R&S	ESCI	100234	04/26/2022	04/25/2023						
Current Sensor Probe	Teseq	CSP 9160A	76115	08/29/2022	08/28/2023						
Test S/W	·	E7	Z-EMC Ver.CCS-03	3A1							

Testing Site : No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan

Measurement Uncertainty of Conducted Emission

Expanded uncertainty Ulab (k=2) of Conducted Emission is 2.8 dB.

Expanded uncertainty Ulab (k=2) of ISN Conducted Emission is 2.8 dB.

Expanded uncertainty CISPR 16-4-2:2011+A1:2014+A2:2018 (k=2) of Conducted Emission measurement is 3.8 dB.

Expanded uncertainty CISPR 16-4-2:2011+A1:2014+A2:2018 (k=2) of ISN Conducted Emission measurement is 4.0 dB.

#### 2.2.2 Measurement Level Calculation

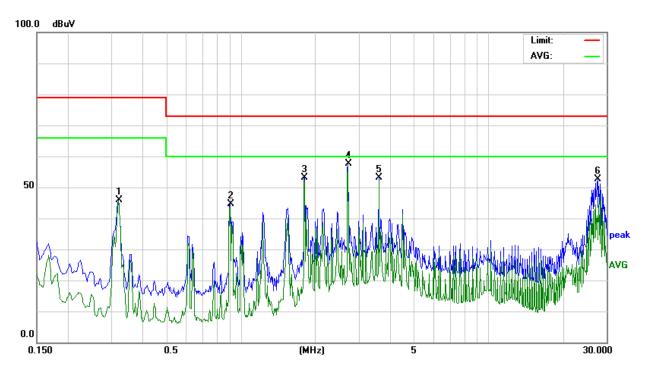
Factor = LISN insertion loss + Cable loss + Pulse Limiter insertion loss Measurement Level = Reading Level + Factor Over (Margin) = Measurement Level – Limit



Page: 11 of 50

## 2.2.3 Measurement Data (CE)

Model No.	AV600	6dB Bandwidth	9 kHz
Environmental Conditions	19.8°C, 64% RH	Test Mode	Mode 1
Tested by	lan Su	Phase	L1
Standard	EN 55032 CLASS A		



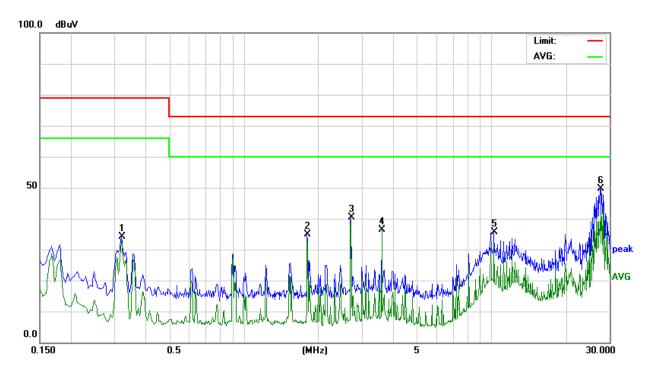
Conducted Emission Readings										
Frequ	Frequency Range Investigated				150 kHz to	30 MHz				
Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector (P/Q/A)	Line (L1/L2)			
0.3209	35.44	10.33	45.77	79.00	-33.23	Р	L1			
0.9060	34.26	10.38	44.64	73.00	-28.36	Р	L1			
1.8060	42.69	10.48	53.17	73.00	-19.83	Р	L1			
2.7105	46.96	10.55	57.51	73.00	-15.49	Р	L1			
3.6150	42.43	10.58	53.01	73.00	-19.99	Р	L1			
27.5640	41.40	11.29	52.69	73.00	-20.31	Р	L1			

**Note:** 1. L1 = Line One (Live Line) / L2 = Line Two (Neutral Line).



Page: 12 of 50

Model No.	AV600	6dB Bandwidth	9 kHz
Environmental Conditions	19.8°C, 64% RH	Test Mode	Mode 1
Tested by	Ian Su	Phase	L2
Standard	EN 55032 CLASS A		



	Conducted Emission Readings										
Frequ	Frequency Range Investigated				150 kHz to	30 MHz					
Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector (P/Q/A)	Line (L1/L2)				
0.3209	23.74	10.30	34.04	79.00	-44.96	Р	L2				
1.8059	24.42	10.44	34.86	73.00	-38.14	Р	L2				
2.7105	29.79	10.50	40.29	73.00	-32.71	Р	L2				
3.6150	25.89	10.53	36.42	73.00	-36.58	Р	L2				
10.2524	24.81	10.70	35.51	73.00	-37.49	Р	L2				
27.5595	38.32	11.24	49.56	73.00	-23.44	Р	L2				

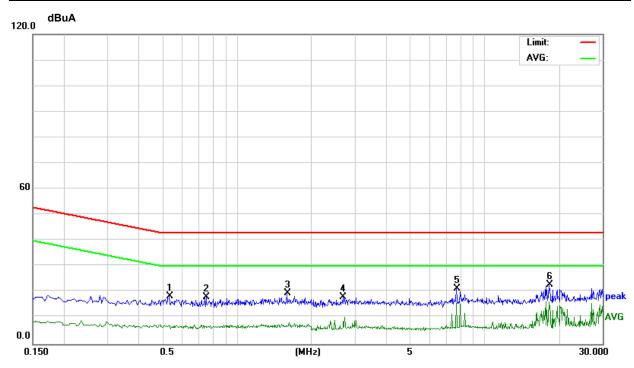
**Note:** 1. L1 = Line One (Live Line) / L2 = Line Two (Neutral Line).



Page: 13 of 50

## 2.2.4 Measurement Data (ISN)

Model No.	AV600	6dB Bandwidth	9 kHz
Environmental Conditions	19.8°C, 64% RH	Test Mode	Mode 2
Tested by	Ian Su	Standard	EN 55032 CLASS A



	Conducted Emission Readings										
Frequency Range Investigated				150	150 kHz to 30 MHz						
Freq. (MHz)	Reading (dBuA)	Factor (dB)	Result (dBuA)	Limit (dBuA)	Margin (dB)	Detector (P/Q/A)					
0.5325	8.01	10.58	18.59	43.00	-24.41	Р					
0.7530	7.54	10.58	18.12	43.00	-24.88	Р					
1.5990	9.00	10.64	19.64	43.00	-23.36	Р					
2.6880	7.36	10.71	18.07	43.00	-24.93	Р					
7.6920	10.51	10.82	21.33	43.00	-21.67	Р					
18.2445	11.88	10.97	22.85	43.00	-20.15	Р					



Page: 14 of 50

#### 2.3 Radiated Emission

#### 2.3.1 Test Instruments

#### **Below 1GHz**

	Open Area Test Site # H										
EQUIPMENT TYPE	Manufacturer	Model Number	Calibration Date	Calibration Due							
Bilog Antenna	Teseq	CBL 6112D	35411	05/04/2023	05/03/2024						
Cable	EMEC	CFD400E-LW	SD-R074	08/11/2022	08/10/2023						
EMI Test Receiver	R&S	ESCI	101340	02/04/2023	02/03/2024						
Pre-Amplifier	HP	8447D	1937A01554	09/22/2022	09/21/2023						
Thermo-Hygro Meter	Wisewind	201A	No. 03	05/23/2023	05/22/2024						
Test S/W		EZ-EMC Ver.CCS-03A1									

Testing Site: No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan

Measurement Uncertainty of Radiated Emission

Expanded uncertainty Ulab (k=2) of Radiated Emission is 5.1 dB.(30MHz-1000MHz)

Expanded uncertainty CISPR 16-4-2:2011+A1:2014+A2:2018 (k=2) of Radiated Emission measurement is 5.2 dB.(30MHz-1000MHz)

#### **Above 1GHz**

	Chamber # E										
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due						
Horn Antenna	ETS	3117	00139062	07/06/2022	07/05/2023						
Microflex Cable x 7m	EMCI	EMC107-NM- NM-7000	SD-R077	07/05/2022	07/04/2023						
K-Type Cable x 1m	EMCI	EMC101G-KM- KM-1000	SD-R075	07/05/2022	07/04/2023						
Pre-Amplifier	Com-Power	PAM-118A	551041	06/28/2022	06/27/2023						
Signal Analyzer	R&S	FSV40	101269	06/24/2022	06/23/2023						
Thermo-Hygro Meter	Wisewind	201A	SD-R046	08/01/2022	07/31/2023						
Test S/W		EZ-EI	MC Ver.CCS-03A	1							

Testing Site: No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan

Measurement Uncertainty of Radiated Emission

Expanded uncertainty (k=2) of Radiated Emission measurement is 4.6 dB.(1-6GHz)

Expanded uncertainty CISPR 16-4-2:2011+A1:2014+A2:2018 (k=2) of Radiated Emission measurement is 5.5 dB.(1-6GHz)

#### 2.3.2 Measurement Level Calculation

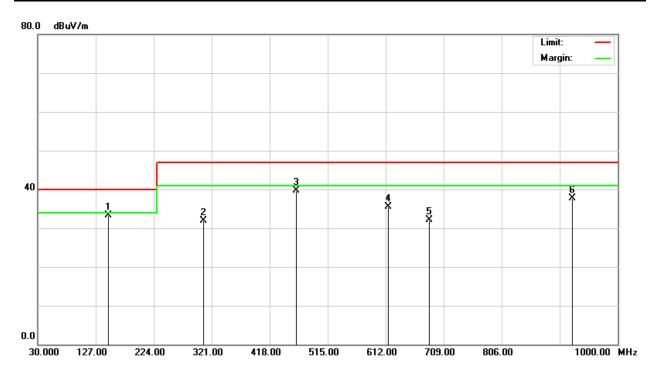
Correction Factor = Antenna Factor + Cable loss- Amplifier Gain Measurement Level = Reading Level + Correction Factor Over (Margin) = Measurement Level – Limit



Page: 15 of 50

# 2.3.3 Measurement Data Below 1GHz

Model No.	AV600	Test Mode	Mode 1
Environmental Conditions	32°C, 59% RH	6dB Bandwidth	120 kHz
Antenna Pole	Vertical	Antenna Distance	10m
Detector Function	Quasi-peak.	Tested by	Alee Shen
Standard	EN 55032 CLASS A		



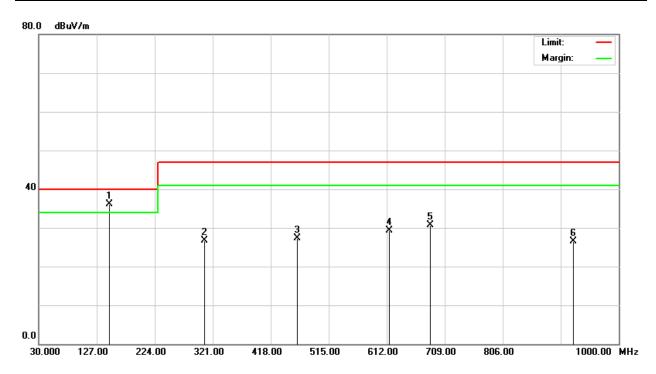
	Radiated Emission Readings									
Frequency Range Investigated			30 M	Hz to 10	00 MHz a	at 10m				
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Lin (dBu)		Margin (dB)	Height (cm)	Degree (°)	Detector (P/Q)	Pol. (H/V)
148.5079	42.60	-9.34	33.26	40.	00	-6.74	100	209	Q	V
308.0020	37.80	-5.80	32.00	47.	00	-15.00	100	152	Q	V
462.1100	41.20	-1.46	39.74	47.	00	-7.26	400	117	Q	V
616.0000	34.00	1.57	35.57	47.	00	-11.43	400	105	Q	٧
684.7580	30.50	1.70	32.20	47.	00	-14.80	400	265	Q	٧
924.0300	33.80	3.91	37.71	47.	00	-9.29	400	124	Q	٧

Note: P= Peak Reading; Q= Quasi-peak Reading.



Page: 16 of 50

Model No.	AV600	Test Mode	Mode 1
Environmental Conditions	32°C, 59% RH	6dB Bandwidth	120 kHz
Antenna Pole	Horizontal	Antenna Distance	10m
Detector Function	Quasi-peak.	Tested by	Alee Shen
Standard	EN 55032 CLASS A		



	Radiated Emission Readings											
Frequency Range Investigated					30 M	Hz to 10	00 MHz a	at 10m				
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Lin (dBu)		Margin (dB)	Height (cm)	Degree (°)	Detector (P/Q)	Pol. (H/V)		
148.5160	45.50	-9.34	36.16	40.	00	-3.84	400	198	Q	Н		
308.0400	32.50	-5.80	26.70	47.	00	-20.30	400	224	Q	Н		
462.1130	28.80	-1.46	27.34	47.	00	-19.66	100	220	Q	Н		
616.0040	27.80	1.57	29.37	47.	00	-17.63	100	120	Q	Н		
685.4220	29.00	1.70	30.70	47.	00	-16.30	100	154	Q	Н		
924.0080	22.50	3.91	26.41	47.	00	-20.59	100	215	Q	Н		

Note: P= Peak Reading; Q= Quasi-peak Reading.



Page: 17 of 50

#### **Above 1GHz**

Model No.	AV600	Test Mode	Mode 1
Environmental Conditions	24.8°C, 58% RH	6dB Bandwidth	1 MHz
Antenna Pole	Vertical / Horizontal	Antenna Distance	3m
Highest frequency generated or used	2600MHz	Upper frequency	6000MHz
Detector Function	Peak and average.	Tested by	James Chou
Standard	EN 55032 CLASS A		

	Radiated Emission Readings										
Frequency Range Investigated				Above 1GHz at 3m							
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector (P/A)	Pol. (H/V)				
1075.000	67.50	-8.56	58.94	76.00	-17.06	Р	V				
1078.045	56.61	-8.55	48.06	56.00	-7.94	Α	٧				
1230.000	62.76	-7.66	55.10	76.00	-20.90	Р	٧				
2310.000	57.27	-4.61	52.66	76.00	-23.34	Р	٧				
2925.000	57.75	-3.92	53.83	76.00	-22.17	Р	٧				
3695.000	58.21	-3.16	55.05	80.00	-24.95	Р	٧				
3850.000	63.04	-3.21	59.83	80.00	-20.17	Р	V				

	Radiated Emission Readings										
Frequency Range Investigated			Above 1GHz at 3m								
Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector (P/A)	Pol. (H/V)				
1075.000	67.93	-8.56	59.37	76.00	-16.63	Р	Н				
1077.897	56.31	-8.55	47.76	56.00	-8.24	Α	Н				
1230.000	63.68	-7.66	56.02	76.00	-19.98	Р	Н				
1231.954	54.41	-7.66	46.75	56.00	-9.25	Α	Н				
2000.000	60.73	-4.88	55.85	76.00	-20.15	Р	Н				
2155.000	59.13	-5.24	53.89	76.00	-22.11	Р	Н				
3695.000	57.33	-3.16	54.17	80.00	-25.83	Р	Н				
3850.000	62.39	-3.21	59.18	80.00	-20.82	Р	Н				

Note: 1. P= Peak Reading; A= Average Reading.



Page: 18 of 50

## 3. Harmonics

#### 3.1 Test Instruments

Immunity A									
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due				
Testing Site: No.1	163-1, Jhongsheng	Testing Site : No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan							

#### 3.2 Measurement Data

Remark: N/A: The subject equipment is not intended to be connected to AC mains supply. Therefore, this test is not applicable



Page: 19 of 50

## 4. Flicker

#### 4.1 Test Instruments

Immunity A									
Testing Site: No.	163-1, Jhongsheng	g Rd., Xindian Dist	., New Taipei City,	Taiwan					

#### 4.2 Measurement Data

Remark: N/A: The subject equipment is not intended to be connected to AC mains supply. Therefore, this test is not applicable



Page: 20 of 50

## **5.IMMUNITY**

#### 5.1 STANDARD PERFORMANCE CRITERIA DESCRIPTION

- Criterion A The apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- Criterion B The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- Criterion C Temporary loss of function is allowed, provided the function is self recoverable or can be restored by the operation of the controls.



Page: 21 of 50

#### 5.2 SPECIAL PERFORMANCE CRITERIA DESCRIPTION

#### 5.2.1 Performance Criteria Description for Print function

- Criterion A Apply criterion A as defined in 8.2. Additionally, the following shall not occur as a consequence of the application of the disturbance:
  - · change of operating state;
  - unintended pausing of the print operation;
  - a change of print quality or legibility, as appropriate to the test pattern;
  - · change of character font;
  - unintended line feed;
  - · unintended page feed;
  - paper feed failure.
- Criterion B Apply criterion B as defined in 8.3 with the following specifics and additional limitations. Paper feed failures are allowed only if, after removal of the jammed sheets, the job is automatically recovered and there is no loss of printed information. Any low-quality print output caused by the application of the disturbance shall not continue beyond the sheet of media being printed, or beyond the typical length of a finished page or sheet printed from continuous roll media. False indicators are permitted during the test provided that a normal operator response to that false indicator is simple (such as pressing a button). False indicators are not acceptable if they would cause the user to discard printing supplies such as ink, toner or paper, when those supplies are actually not empty or faulty. Any false indicator shall either clear automatically or after the operator's response. After the disturbance, the print function may print the remainder of the print job at a quality level within the manufacturer's specifications. Alternately, the print function may halt processing of a print job as a result of the disturbance, but only if the operator is capable of reprinting the job (for example, a fax printing job where the image to be printed still resides in local memory). Automatically restarting the print job from the beginning is also acceptable. In any scenario, the pairing of front and back images during double-sided printing shall be correct.
- Criterion C Temporary loss of function is allowed, provided the function is self recoverable or can be restored by the operation of the controls.



Page: 22 of 50

#### 5.2.2 Performance Criteria Description for Scan function

- Criterion A Apply criterion A as defined in 8.2. Additionally, the following shall not occur as a consequence of the application of the test:
  - change of settings, such as which side(s) of the page to be scanned, colour or monochrome, and resolution;
  - corruption of the image, for example stretching, compressing or change in colour;
  - paper feed failures;
  - errors in the reading of bar codes.
- Criterion B Apply criterion B as defined in 8.3 with the following specifics and additional limitations.
  - Document feed failures are allowed only if the original documents are undamaged and, after removal of the jammed sheets, the job is automatically recovered and there is no loss of scanned information.
  - During the test, the representation of the image shall not be degraded such that reading mistakes occur.
- Criterion C Temporary loss of function is allowed, provided the function is self recoverable or can be restored by the operation of the controls.

## 5.2.3 Performance Criteria Description for Display and display output function

- Criterion A Apply criterion A as defined in 8.2. Additionally, an increase in any degradation greater than just perceptible by observation of the image shall not occur as a consequence of the application of the test.

  Examples of such degradations are:
  - superimposed patterning;
  - positional disturbances due to synchronisation errors;
  - geometric distortion:
  - · change of contrast or brightness;
  - picture artefacts;
  - · freezing or disturbance of motion;
  - · image loss;
  - · video data or decoding errors.
- Criterion B The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- Criterion C Temporary loss of function is allowed, provided the function is self recoverable or can be restored by the operation of the controls.



Page: 23 of 50

#### 5.2.4 Performance Criteria Description for Musical tone generating function

Criterion A - Performance criterion A is subdivided according to the type of equipment and its use. Three subgroups corresponding to different equipment types are defined in Table E.1 and have corresponding performance criteria A1, A2 and A3. The relevant subgroup shall be selected by the manufacturer in accordance with the product specification. The description of criteria A1, A2 and A3 are presented in Table E.2.

- Criterion B During the test, degradation of performance beyond that defined in criterion A1 of Table E.2 is allowed. However, sudden amplification of tone to a level that exceeds the expected level by more than 6 dB is not allowed. After the test, normal operation of the EUT shall be self-recovered. In the case of unintended tone holding caused by a MIDI protocol communication error, the EUT can be re-initialised by the operation of the controls by the user controls in accordance with the manufacturer's instructions. Due to the nature of the MIDI protocol, it is necessary to modify the performance criterion B to allow user intervention when the unintended tone holding is caused by a missing MIDI communication error (for example missing a 'NOTE OFF' message).
- Criterion C Degradation of the performance beyond that defined in criterion A1 of Table E.2 is permitted provided that the normal operation of the EUT can be restored after the test by operator intervention. However, sudden amplification of tone to a level that exceeds the expected level by more than 6 dB is not allowed.



Page: 24 of 50

#### 5.2.5 Performance Criteria Description for Networking function

Criterion A - Where relevant, during the application of the test the network function shall, as a minimum, operate ensuring that:

- established connections shall be maintained throughout the application of the test;
- no change of operational state or corruption of stored data occurs;
- no increase in error rate above the figure defined by the manufacturer occurs. The manufacturer should select the most appropriate performance measurement criteria for the product or system, for example bit error rate, block error rate;
- no request for retry above the figure defined by the manufacturer;.
- the data transmission rate does not reduce below the figure defined by the manufacturer;
- no protocol failure occurs;
- the audio noise level at a two-wire analogue interface (supporting telephony) shall satisfy the requirements of Table G.3. The audio level measurements shall be performed at the demodulated frequency of the disturbance using a narrowband filter with a 3 dB bandwidth of 100 Hz using the method defined in table clause G.1.4. See G.6.1. As described in the example given in J.3.5 the networking function is monitored during testing using direct functions specified elsewhere in this document. If needed to verify the operation of the protocol, the following functions shall be verified as described in Table H.1 when performing the additional spot frequency tests contained in Clause 5:
- ability to establish a connection,
- · ability to clear a connection.

Where an EUT has supervisory functions they shall not be affected. Elements that should be monitored include, but are not limited to:

- · alarms,
- · signalling lamps,
- printer output errors,
- network traffic rates,
- · network monitor errors.
- measured network parameters.



Page: 25 of 50

Criterion B - Established connections shall be maintained throughout the test, or shall self-recover in a way and timescale that is imperceptible to the user.

The error rate, request for retry and data transmission rates may be degraded during the application of the test. Degradation of the performance as described in criterion A is permitted, provided that the normal operation of the EUT is self-recoverable to the condition established prior to the application of the test. Where required, as defined in Clause 5, the acceptable operation of the function shall be verified at the completion of the test as described in Table H.1, by confirming the following:

- the EUT's ability to establish a connection,
- the EUT's ability to clear a connection.

During surge testing disconnection is allowed on the analogue/digital data port being tested. If the EUT is a supervisory equipment, it shall not impact the normal operation of the network being monitored. In addition, any supervisory functions impacted during the period of the test shall return to the state prior to the test. Elements to consider include:

- · alarms,
- · signalling lamps,
- printer output,
- network traffic rates,
- network monitoring. is used as intended.
- Criterion C Degradation of performance as described in criteria A and B is permitted provided that the normal operation of the EUT is self-recoverable to the condition immediately before the application of the test, or can be restored after the test by the operator.



Page: 26 of 50

#### 5.2.6 Performance Criteria Description for Audio output function

Criterion A - The interference ratio (electrical or acoustic) shall meet the limits in column 3; or,

the acoustic level of the demodulated audio shall be less than the limits in column 4; or,

the digitally coded level of demodulated audio shall be less than limits in column 5; or,

the analogue level of the demodulated audio shall be less than the limits in column 6.

- Criterion B The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- Criterion C Temporary loss of function is allowed, provided the function is self recoverable or can be restored by the operation of the controls.

#### 5.2.7 Performance Criteria Description for Telephony function

Function to be exercised	Performance criteria						
Function to be exercised	Α	В	С				
Establish new communication	At the additional spot frequency tests a, c	Performed before and after the application of the test or disturbance	Performed before and after the application of the test or disturbance				
Maintain established communication	Yes In addition, the requirements of Annex G for the audio output function shall be satisfied c	Yes b	No				
Terminate established communication	At the additional spot frequency tests a, c	Performed before and after the application of the test or disturbance	Performed before and after the application of the test or disturbance				

Communication refers to a telephone call or other form of voice connection.

a Applicable to TTE with a dial function that provides dedicated emergency service/safety of life call capability. Where the EUT does not provide this functionality, this limitation shall be stated in the equipment user manual.

b Communication shall be established prior to the application of the disturbance, the communication shall be maintained and the quality of that communication (for example, volume setting, the level of background noise) shall be maintained after completion of the test or disturbance.

c Where defined in Clause 5 (for the tests in Table 1 to Table 4), these functional tests shall be performed during the additional spot frequency tests.



Page: 27 of 50

#### 5.3 Test of IEC 61000-4-2

#### 5.3.1 Test Instruments

Immunity Shielded Room									
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due				
Aneroid Barometer	SATO	7610-20	89090	08/04/2022	08/03/2023				
ESD Simulator	Teseq	NSG 438	1581	07/08/2022	07/07/2023				
Thermo-Hygro Meter	Wisewind	201A	SD-S041	12/23/2022	12/22/2023				
Testing Site : No.16	3-1, Jhongsheng	Rd., Xindian Dist	, New Taipei City,	Taiwan					

## 5.3.2 EUT Operating Condition

#### **Environment:**

Temperature	Humidity	Air Pressure
20 °C	49 %RH	1010 hpa



Page: 28 of 50

#### 5.3.3 Results of Electrostatic Discharge Test (ESD)

Model No. : AV600
Tested By : Alee Shen
Tested Date : March 2, 2023

Test Mode : Mode 1

Basic Standard : IEC 61000-4-2 Discharge Impedance : 330 ohm / 150 pF

Discharge Voltage : Air Discharge: ±2, 4, 8 kV

Contact Discharge: <u>+</u>2, 4 kV

HCP/VCP: +2, 4 kV

Polarity : Positive/Negative

Number of Discharge : 10 times at each test point

Discharge Mode : Single Discharge

Discharge Period : 1 second

#### A.Observations:

Test points: 1. Front side. 2. Back side. 3. Left side. 4. Right side.

5. Top side. 6. Bottom side.

Direct A	pplication	Test Ro	esults	
Discharge Level (kV)   Polarity (+/-)   Test Point		Contact Discharge	Air Discharge	
2, 4, 8 (Air.)	+/-	1-6	N/A	N/A
2, 4 (Cont.)	+/-	1-5	A	N/A

**Remark:** A: No degradation of performance or loss of function.

N/A: Not Applicable.

#### **B.Observations:**

**<u>Test points:</u>** 1. Front side. 2. Back side. 3. Left side. 4. Right side.

Indirect A	Application	Test Re	sults	
Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling	Vertical Coupling
2, 4	+/-	1-4	Α	Α

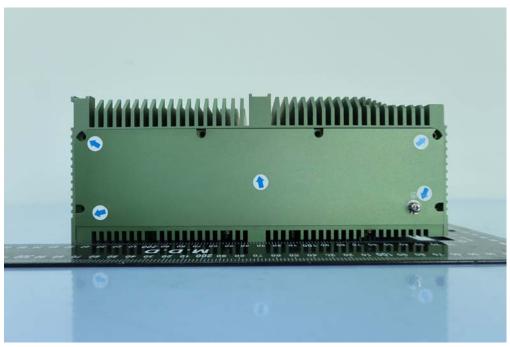
**Remark:** A: No degradation of performance or loss of function.



Page: 29 of 50

## **ESD Test point**

#### **Front**



#### **Back**



Air Discharge: 
Contact Discharge:

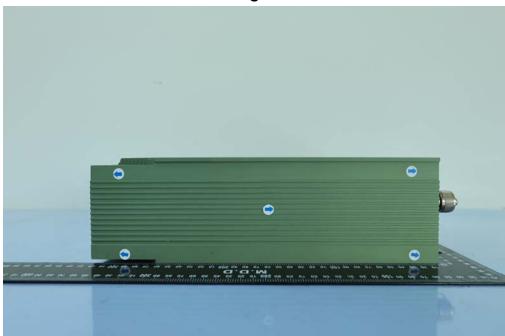


Page: 30 of 50

#### Left



## Right

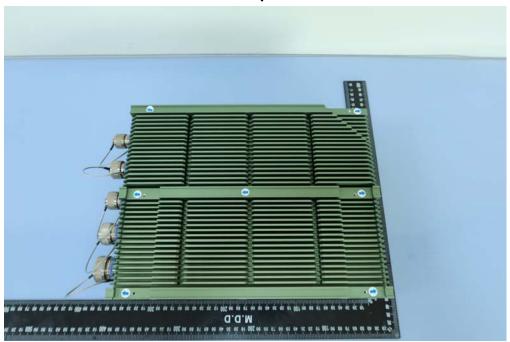


Air Discharge: 1 Contact Disch



Page: 31 of 50

## Top



Air Discharge: 1 Contact Discharge: 1



Page: 32 of 50

## 5.4 Test of IEC 61000-4-3

### 5.4.1 Test Instruments

		844 RS (	Chamber					
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due			
Electric Field Probe	AR	FL7006	0356656	10/15/2022	10/14/2023			
Field of Calibration	CCS	Chamber#RS	80-1000MHz	02/20/2023	02/19/2024			
RF Power Meter	Boonton	4242	17419	02/14/2023	02/13/2024			
Power Sensor	Boonton	51011A-EMC	36833	02/14/2023	02/13/2024			
Power Sensor	Boonton	51011A-EMC	36834	02/14/2023	02/13/2024			
Thermo-Hygro Meter	Wisewind	N/A	SD-S019	09/29/2022	09/28/2023			
Broadband Antenna	AR	AT1080	311819	N.C.R	N.C.R			
Power Amplifier	Teseq	CBA1G-600D	1098099	N.C.R	N.C.R			
Analog Signal Generator	Agilent	E8257D	MY48051214	06/14/2022	06/13/2023			
Field of Calibration	CCS	Chamber#RS	1000-6000MHz	02/17/2023	02/16/2024			
Microwave Antenna	Schwarzbeck	STLP 9149	767	N.C.R	N.C.R			
Power Amplifier	Teseq	CBA6G-100D	1087370	N.C.R	N.C.R			
Test Software								
Testing Site: No.16	3-1, Jhongsheng	Rd., Xindian Dist	., New Taipei City,	Taiwan				

## 5.4.2 EUT Operating Condition

#### **Environment:**

Temperature	Humidity	Air Pressure
24 °C	55 %RH	1010 hpa



Page: 33 of 50

#### 5.4.3 Results of Radiated Radio Frequency Electromagnetic (RS)

Model No. : AV600
Tested By : Alee Shen
Tested Date : March 2, 2023

Test Mode : Mode 1

Basic Standard : IEC 61000-4-3 Frequency range : 80 MHz - 1000 MHz

Frequency range : 1800 MHz, 2600 MHz, 3500 MHz, 5000 MHz (±1%)

Field strength : 3 V/m

Modulation : 80% AM (1kHz)
Frequency step : 1 % of fundamental
Polarity of Antenna : Horizontal and Vertical

Dwell Time : 3 seconds

Test distance : 3 m

No.	Frequency (MHz)	Antenna Orientation	Observation	EUT Orientation
1	80 - 1000	Vertical/Horizontal	Α	0 degree
2	80 - 1000	Vertical/Horizontal	Α	90 degree
3	80 - 1000	Vertical/Horizontal	Α	180 degree
4	80 - 1000	Vertical/Horizontal	Α	270 degree

**Remark:** A: No degradation of performance or loss of function.

No.	Frequency (MHz)	Antenna Orientation	Observation	EUT Orientation
1	1800, 2600, 3500, 5000 (±1%)	Vertical/Horizontal	Α	0 degree
2	1800, 2600, 3500, 5000 (±1%)	Vertical/Horizontal	Α	90 degree
3	1800, 2600, 3500, 5000 (±1%)	Vertical/Horizontal	Α	180 degree
4	1800, 2600, 3500, 5000 (±1%)	Vertical/Horizontal	Α	270 degree

Remark: A: No degradation of performance or loss of function.



Page: 34 of 50

#### 5.5 Test of IEC 61000-4-4

#### 5.5.1 **Test Instruments**

Immunity Shield Room					
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due
Capacitive Clamp	EMC-Partner	CN-EFT1000	589	03/30/2022	03/29/2023
EMC Immunity Tester	EMC Partner	TRANSINT 2000	1117	02/23/2022	02/22/2023
Test Software GenecsVer. 3.27					
Testing Site : No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan					

#### 5.5.2 **EUT Operating Condition**

#### **Environment:**

Temperature	Humidity	Air Pressure
25 °C	52 %RH	1010 hpa

#### 5.5.3 **Results of Electrical Fast Transient (EFT)**

Model No. : AV600 Tested By : Long Liao Tested Date : March 2, 2023

Test Mode : Mode 1

Basic Standard : IEC 61000-4-4 Test Voltage
Signal/Comm. : DC Input: ± 0.5 kV

: ± 0.5 kV

Polarity : Positive/Negative

Impulse Frequency : 5 kHz Tr/Th : 5/50ns Burst : 15ms/300ms

#### Observation:

Test Point	Polarity	Test Level (kV)	Results
L	+/-	0.5	В
N	+/-	0.5	В
PE	+/-	0.5	В
L-N	+/-	0.5	В
L-PE	+/-	0.5	В
N-PE	+/-	0.5	В
L-N-PE	+/-	0.5	В
RJ45	+/-	0.5	А

**Remark:** A: No degradation of performance or loss of function

B: During the test the screen of monitor was flickered. It could become normal after test stop.



Page: 35 of 50

#### 5.6 Test of IEC 61000-4-5

#### 5.6.1 Test Instruments

Immunity Shield Room					
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due
CDN	EMC-Partner	CDN-UTP8	1502	02/22/2023	02/21/2024
EMC Immunity Tester	EMC Partner	TRANSINT 2000	1117	02/22/2023	02/21/2024
Test Software GenecsVer. 3.27					
Testing Site : No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan					

#### 5.6.2 EUT Operating Condition

#### **Environment:**

Temperature	Humidity	Air Pressure
25.6 °C	56 %RH	1005 hpa

#### 5.6.3 Results of Surge Test

Model No. : AV600
Tested By : Long Liao
Tested Date : April 7, 2023
Test Mode : Mode 1

Basic Standard : IEC 61000-4-5

Test Rate : 1 pulse every minute

No. of Tests : 5 positive and 5 negative pulses

Waveform :  $1.2/50 \mu s$  (8/20 $\mu s$ )

#### **Observation Description**

DC input line:

Test Point	Phase Angle (degree)	Polarity (+/-)	Test Level (kV)	Observation
L – PE	No phase angle (degree)	+/-	0.5	Α
N – PE	No phase angle (degree)	+/-	0.5	Α

**Remark:** A: No degradation of performance or loss of function.

Signal line:

Test Rate : 1 pulse every minute

No. of Tests : 5 positive and 5 negative pulses

Waveform : 1.2/50μs (8/20μs)

**Observation Description** 

Signal line:

Olgital line.				
Test Point	Phase Angle (degree)	Polarity (+/-)	Test Level (kV)	Observation
RJ45	No phase angle (degree)	+/-	0.5	Α

**Remark:** A: No degradation of performance or loss of function.



Page: 36 of 50

#### 5.7 Test of IEC 61000-4-6

#### 5.7.1 Test Instruments

		CS Ro	oom		
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due
CDN	Teseq	CDN S751A	46649	10/24/2022	10/23/2023
CDN	Teseq	CDN M016	35821	10/24/2022	10/23/2023
CDN	FCC	FCC-801-M3-25A	9973	10/24/2022	10/23/2023
Compact Immunity Test System	TESEQ	NSG 4070B-35	39581	10/26/2022	10/25/2023
EM Clamp	SCHAFFNER	KEMZ 801	19239	10/24/2022	10/23/2023
Test Software	tware NSG 4070 Control Program V1.2.0				
Testing Site : No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan					

#### 5.7.2 EUT Operating Condition

#### **Environment:**

Temperature	Humidity	Air Pressure
24 °C	56 %RH	1010 hpa

#### 5.7.3 Results of Immunity to Conducted Disturbances (CS)

Model No. : AV600
Tested By : Alee Shen
Tested Date : March 2, 2023

Test Mode : Mode 1

Basic Standard : IEC 61000-4-6 Frequency range : 0.15 MHz -10 MHz

Field strength : 3 Vrms

Frequency range : 10 MHz - 30 MHz Field strength : 3 V to 1Vrms Frequency range : 30 MHz - 80 MHz

Field strength : 1 Vrms

Modulation : 80% AM, 1 kHz Sinewave

Frequency step : 1 % of fundamental

Dwell Time : 3 seconds

Coupling Method : CDN-M2; EM-Clamp

Cable Description	Frequency (MHz)	Observation
DC input	0.15 – 80	Α

#### Signal Ports

Cable Description	Frequency (MHz)	Observation
RJ45	0.15 – 80	Α

Remark: A: No degradation of performance or loss of function.



Page: 37 of 50

### 5.8 Test of IEC 61000-4-8

### 5.8.1 Test Instruments

Immunity Shield Room					
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due
Testing Site : No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan					

## 5.8.2 EUT Operating Condition

#### **Environment:**

Temperature	Humidity	Air Pressure
N/A	N/A	N/A

## 5.8.3 Result of Immunity to Power Frequency Magnetic Field

Model No. : AV600
Tested By : N/A
Tested Date : N/A
Test Mode : N/A

Basic Standard : IEC 61000-4-8

Power Frequency : 50 Hz

Magnetic Field : 1 A/m(r.m.s)
Coil Orientation : X, Y, Z Axis

Observation : N/A

**Remark:** N/A: There is no any sensitive part for magnetic field test. Applicable only to equipment containing susceptible to magnetic field.



Page: 38 of 50

### 5.9 Test of IEC 61000-4-11

### 5.9.1 Test Instruments

Immunity Shielded Room					
EQUIPMENT TYPE	Manufacturer	Model Number	Serial Number	Calibration Date	Calibration Due
Testing Site : No.163-1, Jhongsheng Rd., Xindian Dist., New Taipei City, Taiwan					

## 5.9.2 EUT Operating Condition

### **Environment:**

Temperature	Humidity	Air Pressure	
N/A	N/A	N/A	

## 5.9.3 Results of Voltage Dips Immunity Test

Model No. : AV600
Tested By : N/A
Tested Date : N/A
Test Mode : N/A

Basic Standard : IEC 61000-4-11
EUT Rated Voltage : 230 Volts.
Reduction Voltage : 30, >95 % Ut
Phase Angle : 0,180 degree
Total events : 3 dropouts
Event interval : 10 seconds

Test Power: 230Vac, 50Hz			
Environmental phenomena	Test specification (in periods of the rated frequency)		Observation
Voltage Interruptions	>95	250	N/A
Valtage dina	30	25	N/A
Voltage dips	>95	0.5	N/A

Test Power: 230Vac, 60Hz			
Environmental phenomena	Test specification (% reduction)		
Voltage Interruptions	>95	300	N/A
Voltage dips	30	30	N/A

**Remark:** N/A: The subject equipment is not intended to be connected to AC mains supply. Therefore, this test is not applicable.



Page: 39 of 50

## **APPENDIX**

Photograph of Testing General Set-up

**CE Testing Set-up** 







Page: 40 of 50

## **ISN Testing Set-up**







Page: 41 of 50

RE Testing Set-up
Below 1GHz

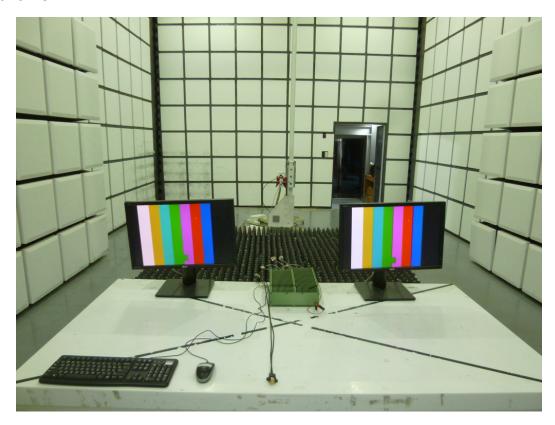


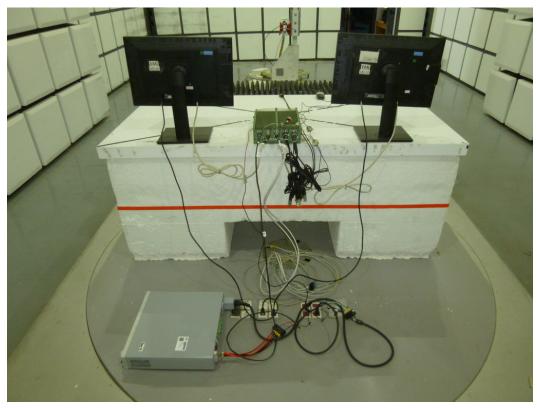




Page: 42 of 50

### **Above 1GHz**





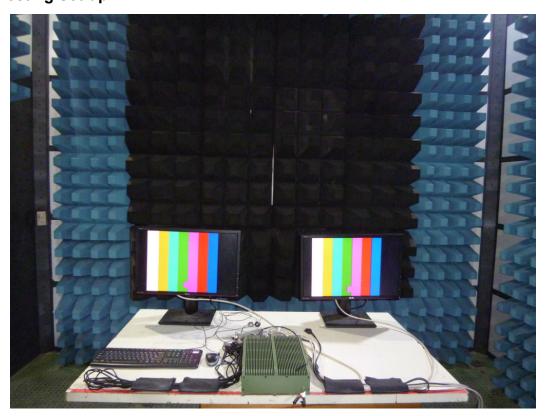


Page: 43 of 50

## **ESD Testing Set-up**



**RS Testing Set-up** 





Page: 44 of 50

## **EFT Testing Set-up**



**EFT For RJ45 Testing Set-up** 





Page: 45 of 50

## **Surge Testing Set-up**



Surge For RJ45 Testing Set-up





Page: 46 of 50

## **CS Testing Set-up**



## **CS For RJ45 Testing Set-up**





Page: 47 of 50

# Photographs of EUT Unit Exterior

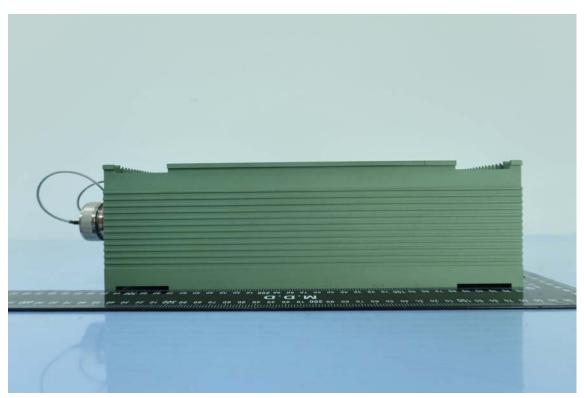






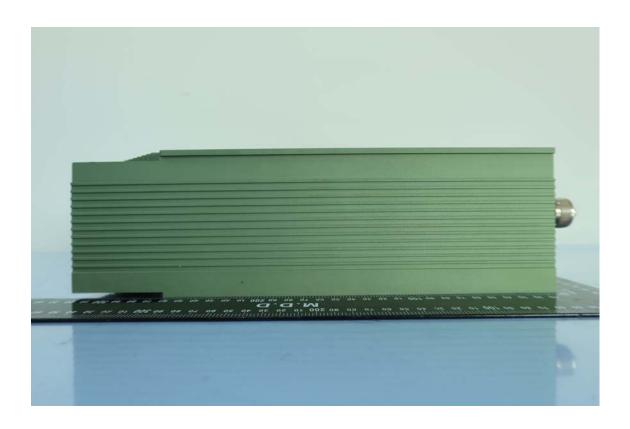
Page: 48 of 50

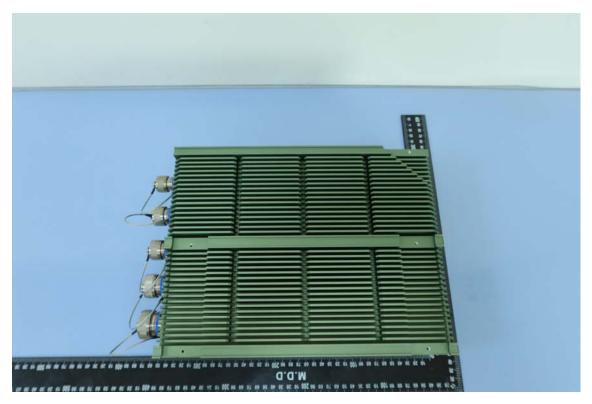






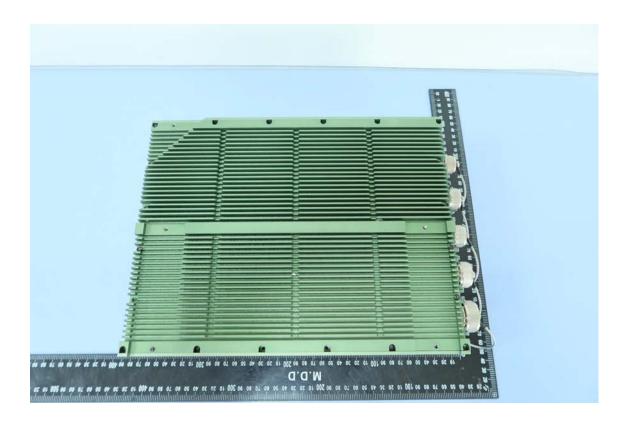
Page: 49 of 50







Page: 50 of 50



\*\* End of Report \*\*